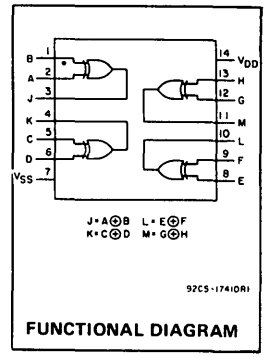
COS/MOS
Quad Exclusive-OR Gate

The RCA-CD4030A types consist of four independent Exclusive-OR gates integrated on a single monolithic silicon chip. Each Exclusive-OR gate consists of four n-channel and four p-channel enhancement-type transistors. All inputs and outputs are protected against electrostatic effects.

These types are supplied in 14-lead hermetic dual-in-line ceramic packages (D and F suffixes), 14-lead dual-in-line plastic package (E suffix), 14-lead ceramic flat package (K suffix), and in chip form (H suffix).



FUNCTIONAL DIAGRAM

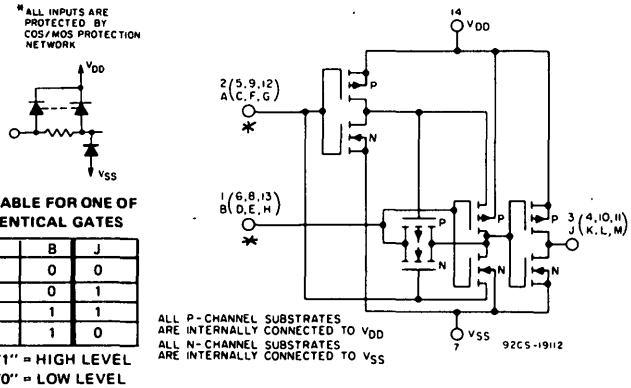
MAXIMUM RATINGS, *Absolute Maximum Values*

STORAGE TEMPERATURE RANGE (T_{stg})	−65 to +150°C
OPERATING TEMPERATURE RANGE (T_A)	
PACKAGE TYPES D F H	−55 to +125°C
PACKAGE TYPE E	−40 to +85°C
DC SUPPLY-VOLTAGE RANGE (V_{DD}) (Voltages referenced to V_{SS} Terminal)	−0.5 to +15 V
POWER DISSIPATION PER PACKAGE (P_D)	
FOR T_A = −40 to +60°C (PACKAGE TYPE E)	500 mW
FOR T_A = +60 to +85°C (PACKAGE TYPE E)	Derate Linearly at 12 mW/°C to 200 mW
FOR T_A = −55 to +100°C (PACKAGE TYPES D F)	500 mW
FOR T_A = +100 to +125°C (PACKAGE TYPES D F)	Derate Linearly at 12 mW °C to 200 mW
DEVICE DISSIPATION PER OUTPUT TRANSISTOR	
FOR T_A = FULL PACKAGE TEMPERATURE RANGE (ALL PACKAGE TYPES)	100 mW
INPUT VOLTAGE RANGE, ALL INPUTS	−0.5 to V_{DD} +0.5 V
LEAD TEMPERATURE (DURING SOLDERING)	
At distance 1/16 ± 1/32 inch (1.59 ± 0.79 mm) from case for 10 s max	+265°C

RECOMMENDED OPERATING CONDITIONS at T_A = 25°C,

For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges.

CHARACTERISTIC	LIMITS				UNITS
	D,F,H Packages		E Package		
	Min.	Max.	Min.	Max.	
Supply Voltage Range (For T_A = Full Package Temperature Range)	3	12	3	12	V



TRUTH TABLE FOR ONE OF FOUR IDENTICAL GATES

A	B	J
0	0	0
1	0	1
0	1	1
1	1	0

WHERE "1" = HIGH LEVEL
"0" = LOW LEVEL

Fig.1 – Schematic diagram for 1 of 4 identical exclusive-OR gates.

For quiescent device current, noise immunity, and input leakage current test circuits see "Ratings and Characteristics" at the beginning of the COS/MOS section.

Features:

- **Medium speed operation. . .**
  . . .t_{PHL} = t_{PLH} = 40 ns (typ.) @ C_L = 15 pF and $V_{DD}-V_{SS}$ = 10 V
- **Low output impedance. . .**
  . . .500 Ω (typ.) @ $V_{DD}-V_{SS}$ = 10 V
- **Quiescent current specified to 15 V**
- **Maximum input leakage current of 1 μA at 15 V (Full package-temperature range)**
- **1-V noise margin (full package-temperature range)**

Applications:

- **Even and odd-parity generators and checkers**
- **Logical comparators**
- **Adders/subtractors**
- **General logic functions**

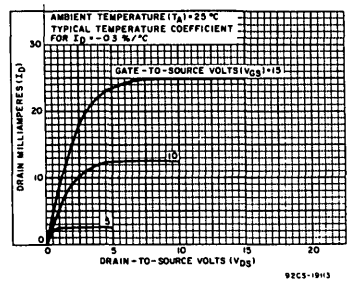


Fig.2 – Typical output n-channel drain characteristics.

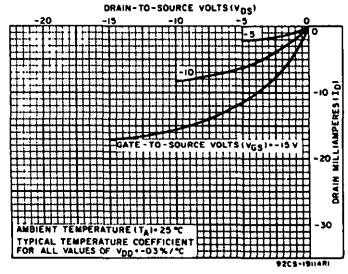


Fig.3 – Typical output p-channel drain characteristics.

CD4030A Typ s

STATIC ELECTRICAL CHARACTERISTICS

Characteristic	Conditions			Limits at Indicated Temperatures (°C)								Units
				D,F,H Packages				E Package				
	V_O (V)	V_{IN} (V)	V_{DD} (V)	−55	+25 Typ.	+25 Limit	+125	−40	+25 Typ.	+25 Limit	+85	
Quiescent Device Current I_L Max	–	–	5	0 5	0.005	0 5	30	5	0.05	5	70	μA
	–	–	10	1	0 01	1	60	10	0.1	10	140	
	–	–	15	25	0 5	25	1000	250	2.5	250	2500	
Output Voltage Low Level, V_{OL}	–	5	5	0 Typ., 0.05 Max.								V
	–	10	10	0 Typ ; 0.05 Max.								
High Level V_{OH}	–	0	5	4.95 Min., 5 Typ.								
	–	0	10	9 95 Min., 10 Typ								
Noise Immunity Inputs Low, V_{NL}	3.6	–	5	1.5 Min., 2.25 Typ.								V
	7 2	–	10	3 Min , 4.5 Typ								
Inputs High V_{NH}	1 4	–	5	1.5 Min , 2 25 Typ								
	2.8	–	10	3 Min , 4 5 Typ.								
Noise Margin: Inputs Low, V_{NML}	4 5	–	5	1 Min.								V
	9	–	10	1 Min.								
Inputs High, V_{NMH}	0.5	–	5	1 Min.								
	1	–	10	1 Min.								
Output Drive Current N Channel (Sink) I_DN Min.	0 5	–	5	0.75	1.2	0 6	0 45	0 35	1.2	0 3	0.25	mA
	0.5	–	10	1.5	2 4	1.2	0.9	0.7	2.4	0 6	0 5	
P Channel (Source). I_DP Min.	4 5	–	5	−0.45	−0 6	−0.3	−0 21	−0.21	−0.6	−0.15	−0 12	
	9.5	–	10	−0 95	−1 3	−0.65	−0 45	−0.45	−1.3	−0 32	−0 25	
Input Leakage Current I_{IL}, I_{IH}	Any Input			± 10^{-5} Typ., ± 1 Max.								μA
	–	–	15									

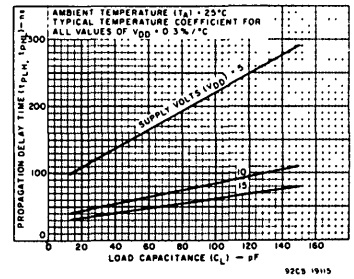


Fig.4 – Typical propagation-delay time vs. load capacitance.

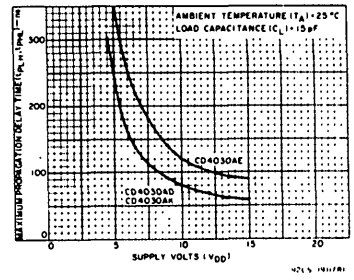


Fig.5 – Maximum propagation-delay time vs. supply voltage.

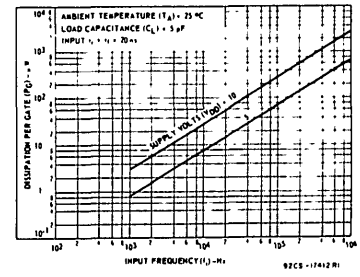


Fig.6 – Typical dynamic power dissipation characteristics.

DYNAMIC ELECTRICAL CHARACTERISTICS at T_A = 25°C, Input t_r, t_f = 20 ns, C_L = 15 pF, R_L = 200 kΩ

Characteristic	Test Conditions		LIMITS						Units
			D,F,H Packages			E Package			
		V_{DD} (V)	Min.	Typ.	Max.	Min.	Typ.	Max.	
Propagation Delay Time: t_{PLH}, t_{PHL}		5	–	100	200	–	100	300	ns
		10	–	40	100	–	40	150	
Transition Time. High-to-Low Level, t_{THL}		5	–	70	150	–	70	300	ns
		10	–	25	75	–	25	150	
Low-to-High Level, t_{TLH}		5	–	80	150	–	80	300	
		10	–	30	75	–	30	150	
Average Input Capacitance, C_I	Any Input		–	5	–	–	5	–	pF

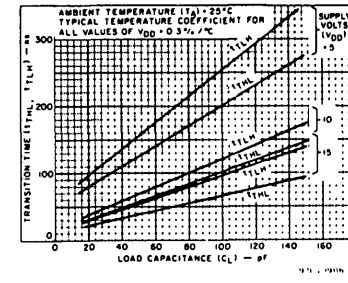


Fig.7 – Typical transition time vs. load capacitance.